

<b>Notice of References Cited</b>	Application/Control No. 09/811,897	Applicant(s)/Patent Under Reexamination YAMAMUA	
	Examiner Dah-Wei D. Yuan	Art Unit 1745	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,316,877	05-1994	Thackeray et al.	429/338
	B	US-5,658,693	08-1997	Thackeray et al.	429/224
	C	US-6,168,887	01-2001	Dahn et al.	429/224
	D	US-6,232,021	05-2001	Negoro, Masayuki	429/328
	E	US-6,316,147	11-2001	Kihira et al.	429/231.8
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
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	X	

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